







CSD25211W1015 SLPS296B - FEBRUARY 2012 - REVISED SEPTEMBER 2022

CSD25211W1015, P-Channel NexFET™ Power MOSFET

1 Features

- Ultra-low on resistance
- Ultra-low $\mathbf{Q}_{\mathbf{g}}$ and $\mathbf{Q}_{\mathbf{gd}}$
- Small footprint 1.0 mm × 1.5 mm
- Low profile 0.62 mm height
- Pb Free
- Gate-source voltage clamp
- Gate ESD protection 3 kV
- RoHS compliant
- Halogen free

2 Applications

- **Battery Management**
- Load Switch
- **Battery Protection**

3 Description

The device is designed to deliver the lowest on resistance and gate charge in the smallest outline possible with excellent thermal characteristics in an ultra-low profile.

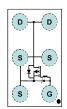
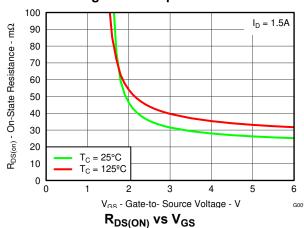


Figure 3-1. Top View



Product Summary

T _A = 25°	C unless otherwise stated	TYPICAL VA	UNIT		
V _{DS}	Drain-to-Source Voltage	-20	V		
Qg	Gate Charge Total (-4.5V)	3.4	nC		
Q _{gd}	Gate Charge Gate to Drain	0.2	0.2		
В	Drain-to-Source On Resistance	V _{GS} = -2.5 V	36	mΩ	
R _{DS(on)}	Dialii-to-Source Off Resistance	V _{GS} = -4.5 V	27	mΩ	
V _{GS(th)}	Voltage Threshold	-0.8	V		

Ordering Information

Device	Package	Media	Qty	Ship	
CSD25211W1015	1 × 1.5 Wafer Level Package	7-inch reel	3000	Tape and Reel	

Absolute Maximum Ratings

T _A = 2	5°C unless otherwise stated	VALUE	UNIT	
V _{DS}	Drain-to-Source Voltage	-20	V	
V _{GS}	Gate-to-Source Voltage	-6	V	
I _D	Continuous Drain Current, T _A = 25°C ⁽¹⁾	-3.2	Α	
I _{DM}	Pulsed Drain Current, T _A = 25°C ⁽²⁾	-9.5	Α	
	Continuous Gate Current, T _A = 25°C	-0.5	Α	
I _G	Pulsed Gate Current	-7	Α	
P _D	Power Dissipation ⁽¹⁾	1	W	
T _{STG}	Storage Temperature Range	-55 to 150	°C	
TJ	Operating Junction Temperature Range	-55 10 150		

- Typical $R_{\theta JA}$ = 119°C/W on 1 inch² of 2 oz. Cu on 0.06-inch thick FR4 PCB.
- Pulse width ≤ 10 µs, duty cycle ≤ 2%

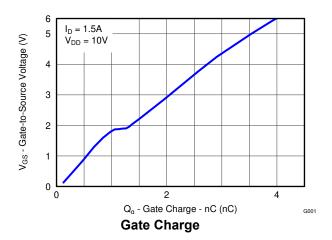




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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision A (January 2014) to Revision B (September 2022)

Page

• In the Absolute Maximum Ratings table Continuous Drain Current was changed to Continuous Gate Current.

......1

In the Absolute Maximum Ratings table Pulsed Drain Current was changed to Pulsed Gate Current......1

5 Electrical Characteristics

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

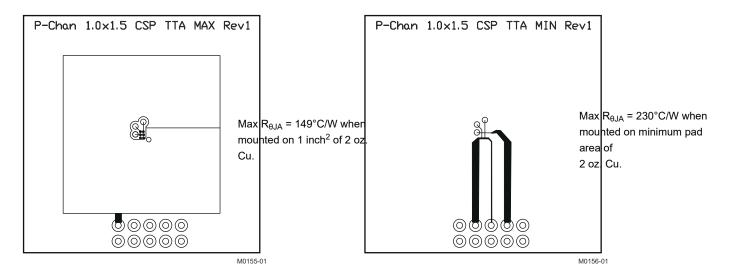
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Static Cl	haracteristics		<u> </u>			
BV _{DSS}	Drain-to-Source Voltage	$V_{GS} = 0 \text{ V, } I_{D} = -250 \mu\text{A}$	-20			V
BV _{GSS}	Gate-to-Source Voltage	$V_{DS} = 0 \text{ V, } I_G = -250 \mu\text{A}$	-6.1		-7.2	V
I _{DSS}	Drain-to-Source Leakage Current	V _{GS} = 0 V, V _{DS} = -16 V			-1	μΑ
I _{GSS}	Gate-to-Source Leakage Current	V _{DS} = 0 V, V _{GS} = -6 V			-100	nA
V _{GS(th)}	Gate-to-Source Threshold Voltage	$V_{DS} = V_{GS}, I_D = -250 \mu A$	-0.5	-0.8	-1.1	V
Р	Drain to Source On Resistance	$V_{GS} = -2.5 \text{ V}, I_D = -1.5 \text{ A}$		36		mΩ
R _{DS(on)}	Drain-to-Source On Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -1.5 \text{ A}$		27	33	mΩ
g _{fs}	Transconductance	$V_{DS} = -10 \text{ V}, I_D = -1.5 \text{ A}$		12		S
Dynamic	Characteristics		'			
C _{ISS}	Input Capacitance			475		pF
C _{OSS}	Output Capacitance	$V_{GS} = 0 \text{ V}, V_{DS} = -10 \text{ V}, f = 1 \text{ MHz}$		234	281	pF
C _{RSS}	Reverse Transfer Capacitance			10.5	13.1	pF
Qg	Gate Charge Total (-4.5 V)			3.4	4.1	nC
Q _{gd}	Gate Charge Gate to Drain	V - 40VI - 45A		0.2		nC
Q _{gs}	Gate Charge Gate to Source	$V_{DS} = -10 \text{ V}, I_D = -1.5 \text{ A}$		1.1		nC
Q _{g(th)}	Gate Charge at V _{th}			0.6		nC
Q _{OSS}	Output Charge	V _{DS} = -10 V, V _{GS} = 0 V		3.8		nC
t _{d(on)}	Turn On Delay Time			13.6		ns
t _r	Rise Time	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -1.5 \text{ A}$		8.8		ns
t _{d(off)}	Turn Off Delay Time	$R_G = 4 \Omega$		36.9		ns
t _f	Fall Time			14.2		ns
Diode Cl	haracteristics		'			
V _{SD}	Diode Forward Voltage	I _S = -1.5 A, V _{GS} = 0 V		-0.8	-1	V
Q _{rr}	Reverse Recovery Charge	V - 40 V I - 4 5 A 48/44 - 200 A 48/4		6.9		nC
t _{rr}	Reverse Recovery Time	V_{dd} = -10 V, I_F = -1.5 A, di/dt = 200 A/ μ s		11.6		ns



6 Thermal Characteristics

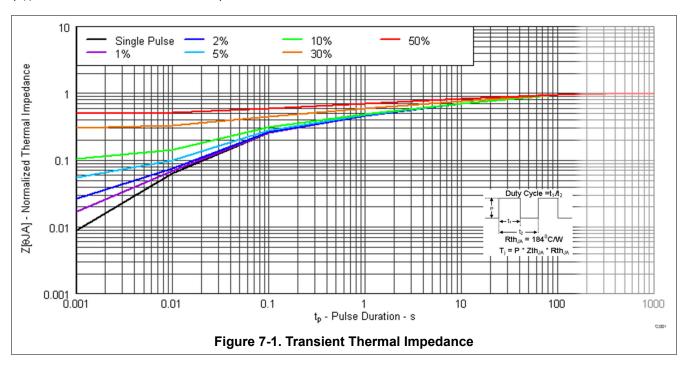
(T_A = 25°C unless otherwise stated)

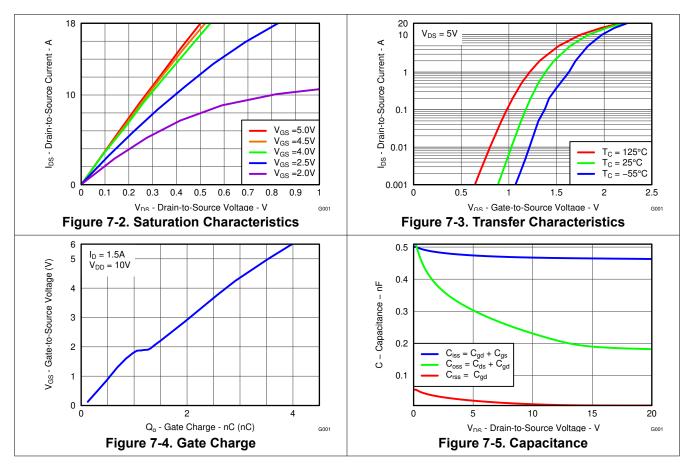
	PARAMETER	MIN	TYP	MAX	UNIT
R _{θJA}	Thermal Resistance Junction to Ambient (Minimum Cu area)			230	°C/W
	Thermal Resistance Junction to Ambient (1 in ² Cu area)			149	°C/W



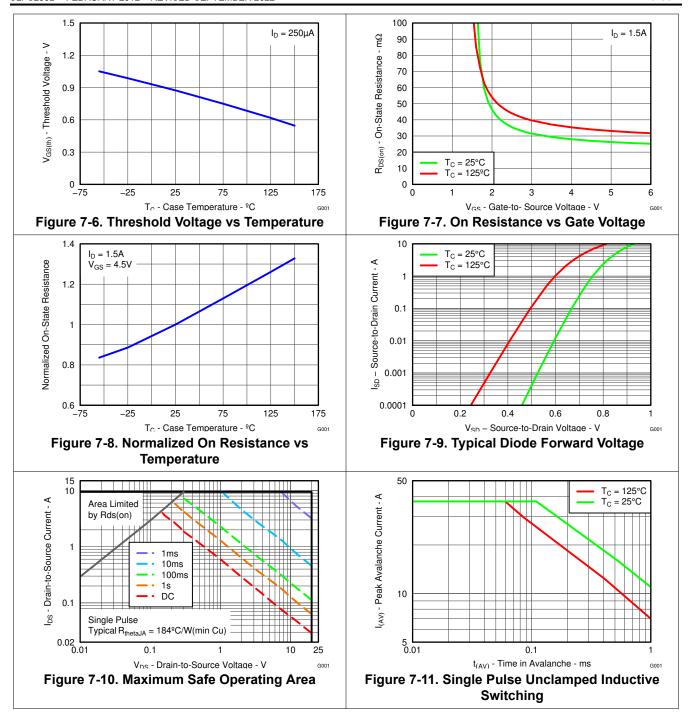
7 Typical MOSFET Characteristics

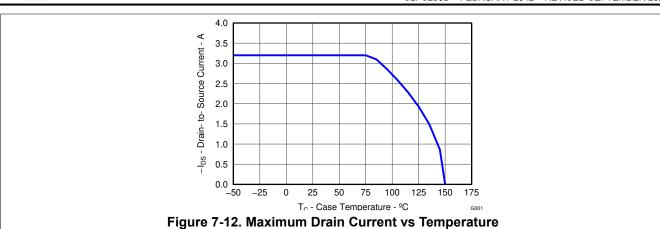
 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$







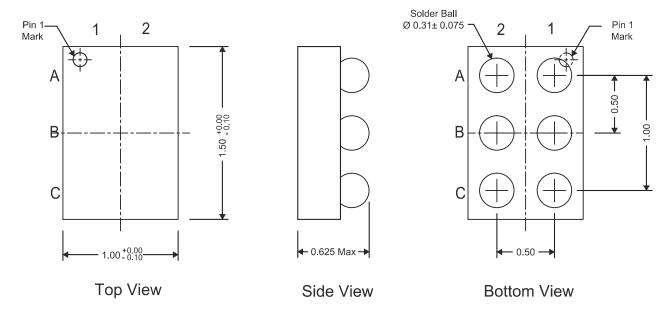


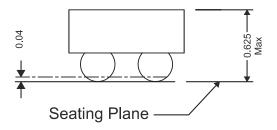




8 Mechanical Data

8.1 CSD25211W1015 Package Dimensions





Front View

All dimensions are in mm (unless otherwise specified)

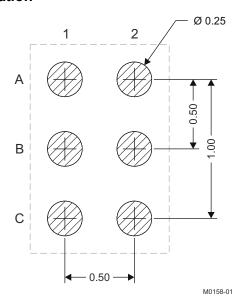
Pinout

POSITION	DESIGNATION				
C1, C2	Drain				
A1	Gate				
A2, B1, B2	Source				

Submit Document Feedback



8.2 Land Pattern Recommendation



All dimensions are in mm (unless otherwise specified)

9 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

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10.6 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

www.ti.com 9-Nov-2025

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
CSD25211W1015	Active	Production	DSBGA (YZC) 6	3000 LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-55 to 150	25211
CSD25211W1015.B	Active	Production	DSBGA (YZC) 6	3000 LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-55 to 150	25211

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

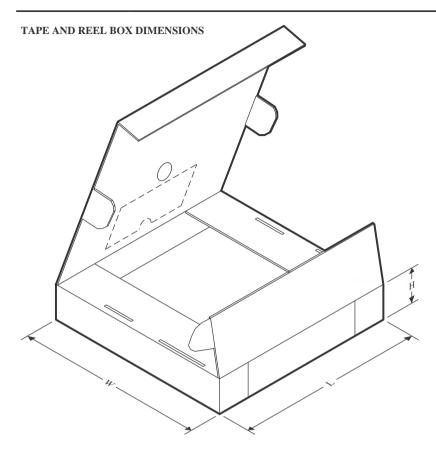


*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CSD25211W1015	DSBGA	YZC	6	3000	180.0	8.4	1.09	1.56	0.65	2.0	8.0	Q1

PACKAGE MATERIALS INFORMATION

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*All dimensions are nominal

Ì	Device	Device Package Type		Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
ı	CSD25211W1015	DSBGA	YZC	6	3000	182.0	182.0	20.0	

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